A Complete Bibliography of Publications in *Technometrics* for the decade 2020–2029

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Gho20, Hus23, Kha23, Lip20a, Lip20b, Lip20d, Lip20c, Lip20e, Lip20h, Lip20f, Lip20g, Lip20i, Lip20j, Lip21b, Lip21c, Lip21g, Lip21f, Lip21e, Lip21d, Lip21j, Lip21l, Lip21m, Lip22d, Lip22a, Lip22b, Lip22e, Lip22l, Lip22f, Lip22i, Lip22k, Lip22j, Lip23a, Lip23b, Lip23f, Lip23c, Lip23d, Lip23g, Lip24a, Lip24b, Lip24g, Lip24e, Lip24d, Lip24f, Liu21, Lu20, Mal22a, Mal22b, Mal22c, Mal23a, Mal23b, Mal23c, Mal23d, Mal23e, MD24, MM24, Mal20, Mal21, Ndo24, Nel21, Oli20, Oli22, Oli24, PTIS24, Rah23, Sa'23a, SHKB24, Sea20, SL24, Tri24, VL21b, Wlu21, Wlu23, Zel22, ZIU+24, ZGAR24, ZRB+24].
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